SI2318CDS-T1-GE3-VB



SI2318CDS-T1-GE3-VB Datasheet

N-Channel 30-V (D-S) MOSFET

PRODUC	CT SUMMARY		
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^a	Q _g (Typ.)
30	0.030 at V _{GS} = 10 V	6.5	4.5 nC
	0.033 at V _{GS} = 4.5 V	6.0	4.5 110

FEATURES

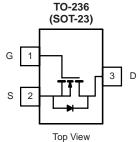
- Halogen-free According to IEC 61249-2-21 Definition
- Trench Power MOSFET
- 100 % R_g Tested
- Compliant to RoHS Directive 2002/95/EC

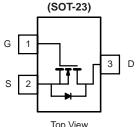
N-Channel MOSFET

APPLICATIONS

DC/DC Converter







ABSOLUTE MAXIMUM RATINGS T_A = 25 °C, unless otherwise noted Parameter Symbol Limit Unit 30 **Drain-Source Voltage** V_{DS} V Gate-Source Voltage V_{GS} ± 20 T_C = 25 °C 6.5^a T_C = 70 °C 6.0 Continuous Drain Current (T_J = 150 °C) I_D T_A = 25 °C 5.3 $T_A = 70 \degree C$ А 5.0 Pulsed Drain Current I_{DM} 25 T_C = 25 °C 1.4 Continuous Source-Drain Diode Current Is T_A = 25 °C 0.9^{b, c} T_C = 25 °C 1.7 T_C = 70 °C 1.1 Maximum Power Dissipation P_D W T_A = 25 °C <u>1.</u>1^{b, c} T_A = 70 °C 0.7^{b, c} Operating Junction and Storage Temperature Range T_J, T_{stg} - 55 to 150 °C Soldering Recommendations (Peak Temperature)^{d, e} 260

THERMAL RESISTANCE RA	TINGS				
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{b, d}	t ≤ 5 s	R _{thJA}	90	115	°C/W
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	60	75	0/11

Notes:

a. Package limited

b. Surface Mounted on 1" x 1" FR4 board.

c. t = 5 s.

d. Maximum under steady state conditions is 130 °C/W.

SPECIFICATIONS $T_J = 25 \ ^{\circ}C$,				1	1	-
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static				T	I	-
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \mu\text{A}$	30			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		31		mV/°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}\!/T_J$	·D = 200 µ/(- 5		11107
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	0.7	1.1	2.0	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA
Zero Gate Voltage Drain Current	lana	$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			1	
Zero Gale voltage Drain Current	IDSS	V_{DS} = 30 V, V_{GS} = 0 V, T_{J} = 55 °C			10	μA
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5$ V, V_{GS} = 10 V	10			Α
	Б	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 3.2 \text{ A}$		0.030		0
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_{D} = 2.8 \text{ A}$		0.033		Ω
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 15 \text{ V}, \text{ I}_{D} = 4.8 \text{ A}$		11		S
Dynamic ^b	<u> </u>				1	
Input Capacitance	C _{iss}			335		
Output Capacitance	C _{oss}	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz		45		pF
Reverse Transfer Capacitance	C _{rss}			17		
-		V _{DS} = 15 V, V _{GS} = 10 V, I _D = 3.4 A		4.5	6.7	
Total Gate Charge	Qg			2.1	3.2	
Gate-Source Charge	Q _{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 3.4 \text{ A}$		0.85		nC
Gate-Drain Charge	Q _{gd}			0.65		
Gate Resistance	R _g	f = 1 MHz	0.8	4.4	8.8	Ω
Turn-On Delay Time	t _{d(on)}			12	20	
Rise Time	t _r	$V_{DD} = 15 \text{ V}, \text{ R}_1 = 5.6 \Omega$		50	75	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 2.7 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		12	20	
Fall Time	t _f	-		22	35	
Turn-On Delay Time	t _{d(on)}			5	10	ns
Rise Time	t _r	$V_{DD} = 15 \text{ V}, \text{ R}_1 = 5.6 \Omega$		12	20	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 2.7 \text{ A}, V_{GEN} = 10 \text{ V}, \text{ R}_g = 1 \Omega$		10	15	
Fall Time	t _f	-		5	10	
Drain-Source Body Diode Characteristic	cs				1	
Continuous Source-Drain Diode Current	ا _S	T _C = 25 °C			1.4	
Pulse Diode Forward Current	I _{SM}				15	A
Body Diode Voltage	V _{SD}	$I_{S} = 2.7 \text{ A}, V_{GS} = 0 \text{ V}$		0.8	1.2	V
Body Diode Reverse Recovery Time	t _{rr}			10	20	ns
Body Diode Reverse Recovery Charge	Q _{rr}			5	10	nC
Reverse Recovery Fall Time	t _a	$I_F = 2.7 \text{ A}, \text{ dl/dt} = 100 \text{ A/}\mu\text{s}, \text{ T}_J = 25 \text{ °C}$		6		
Reverse Recovery Rise Time	t _b			4		ns

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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- 55

°C

2.5

20

V_{GS} = 10 V

75

100

125 150

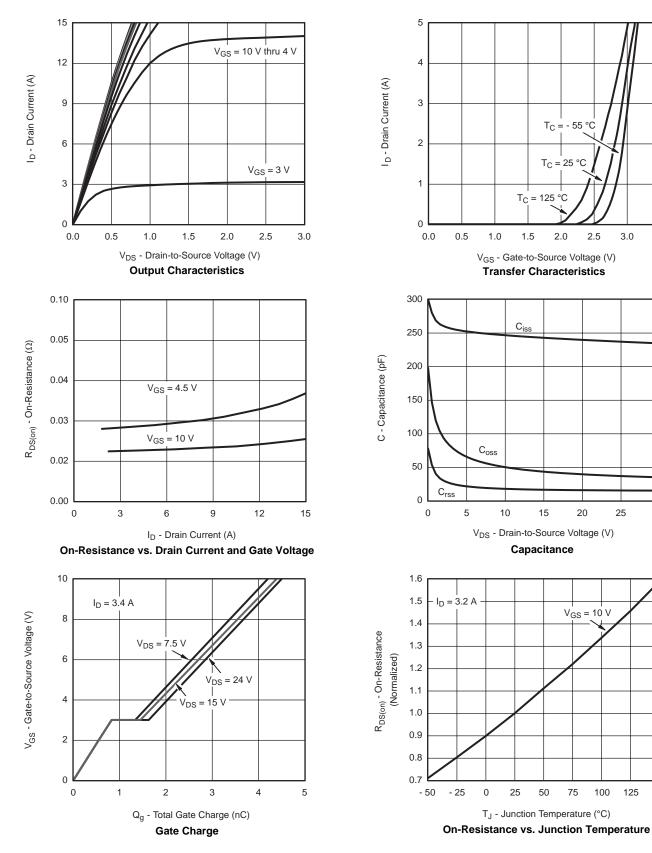
25

30

3.0

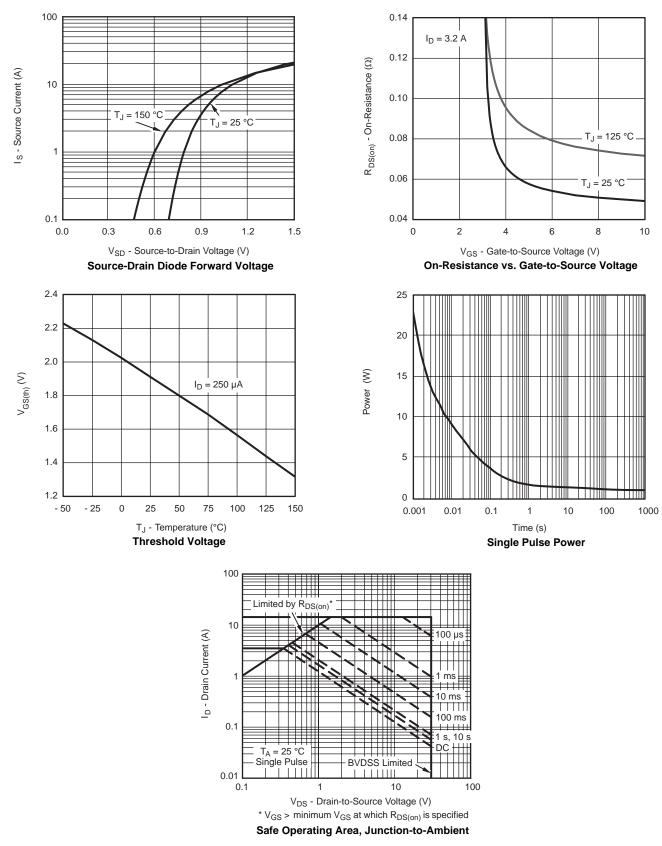
3.5

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



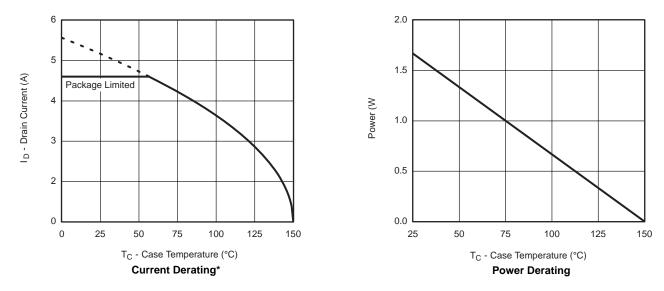


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





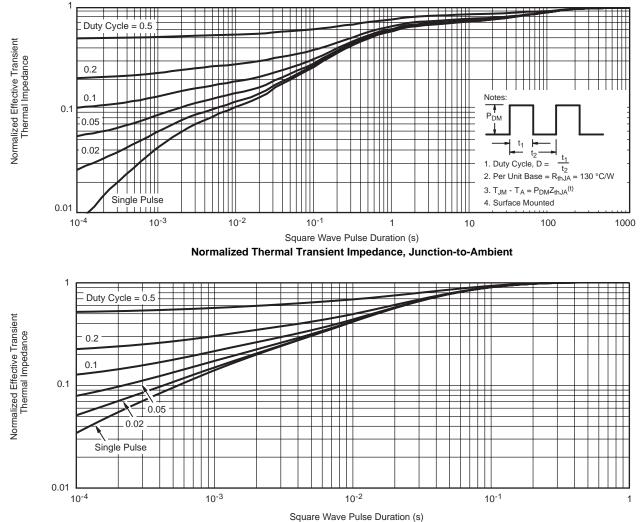
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



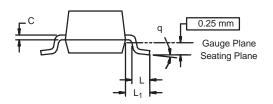
Normalized Thermal Transient Impedance, Junction-to-Foot



SOT-23 (TO-236): 3-LEAD







Max 1.12 0.10 1.02 0.50 0.18 3.04 2.64 1.40	Min 0.035 0.0004 0.0346 0.014 0.003 0.110 0.083	Max 0.044 0.004 0.040 0.020 0.007 0.120 0.104
0.10 1.02 0.50 0.18 3.04 2.64	0.0004 0.0346 0.014 0.003 0.110 0.083	0.004 0.040 0.020 0.007 0.120
1.02 0.50 0.18 3.04 2.64	0.0346 0.014 0.003 0.110 0.083	0.040 0.020 0.007 0.120
0.50 0.18 3.04 2.64	0.014 0.003 0.110 0.083	0.020 0.007 0.120
0.18 3.04 2.64	0.003 0.110 0.083	0.007 0.120
3.04 2.64	0.110 0.083	0.120
2.64	0.083	
		0.104
1 40		
1.40	0.047	0.055
BSC	0.0374	1 Ref
BSC	0.0748	3 Ref
0.60	0.016	0.024
Ref	0.025	Ref
Ref	0.020	Ref
8°	3°	8°
	4 Ref D Ref 8°	0.020 Ref 0.020

SI2318CDS-T1-GE3-VB



RECOMMENDED MINIMUM PADS FOR SOT-23



Recommended Minimum Pads Dimensions in Inches/(mm)

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